

Application/Control	No
10/695 810	

Examiner Hana A. Sanei Applicant(s)/Patent under Reexamination

CHANG ET AL.
Art Unit

2879

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		ORIGINAL				INTERNATIONAL CLASSIFICATION									
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CLASS	SUBCLA	ASS (ONE SI	JBCLASS PE	R BLOCK)					,						
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(Assistant Examiner) (Date) (Legal Instruments Examiner) (Date)										n(s)	O.G. Print Fi				
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Claims renumbered in the same order as presented by applicant									☐ CPA			☐ T.D.			☐ R.1.47				
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
	1	1		31			61	1		91			121			151			181
	2	1		32			62	1		92			122			152			182
	3			33			63	1		93			123			153			183
	4			34			64	1		94			124			154			184
	5			-35			65	1		95			125			155			185
	6			36			66	1		96			126			156			186
	7			37			67]		97			127			157			187
	8			38			68			98			128			158			188
	9			39			69]		99			129			159			189
	10			40			70			100			130			160			190
	11			41			71]		101			131			161			191
	12			42			72			102			132			162			192
	13			43			73			103			133			163]		193
1_	14]		44			74]		104			134			164]		194
2	15			45			75			105			135			165	1		195
3	16			46			76]		106			136	·		166			196
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6	19			49			79]		109			139			169			199
7	20			50			80]		110			140			170			200
	21			51			81			111			141			171			201
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	24			54			84			114			144			174			204
	25			55			85			115			145			175			205
	26			56			86			116			146			176	[206
	27			57			87			117			147			177			207
	28			58			88]		118			148			178			208
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	30			60			90	<u></u>		120			150	l l		180			210